

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/806,642	CHANG, TIANYI	
Examiner	Art Unit	
Shav L. Balsis	1744	

	SEARCHED				
Class	Subclass	Date	Examiner		
15	186 110 106 114 207.2 dig 6	3/14/2006	SB		
upd	ated_	9/15/01	SK		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
east search attached; searched a46b 9/06	3/8/2006	SB		
inventor search done in edan	3/8/2006 9/15/06	sb SK		